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AON2401

8V P-Channel MOSFET

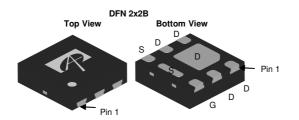
General Description

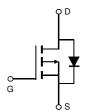
The AON2401 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

Product Summary

V_{DS}	-8V
I_D (at V_{GS} =-2.5V)	-8A
$R_{DS(ON)}$ (at $V_{GS} = -2.5V$)	$<$ 22m Ω
$R_{DS(ON)}$ (at $V_{GS} = -1.8V$)	$<$ 28m Ω
$R_{DS(ON)}$ (at $V_{GS} = -1.5V$)	$<$ 36m Ω
$R_{DS(ON)}$ (at $V_{GS} = -1.2V$)	$<$ 53m Ω







Absolute Maximum Ratings T _A =25 ^o C unless otherwise noted					
Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V_{DS}	-8	V	
Gate-Source Voltage		V_{GS}	±5	٧	
Continuous Drain			-8	^	
Current G	T _A =70℃	'D	-6	— A	
Pulsed Drain Current	C	I _{DM}	-32	A	
	T _A =25℃	P _D	2.8	w	
Power Dissipation ^A	T _A =70℃	L D	1.8	vv	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics					
Parameter		Symbol Typ Max		Units	
Maximum Junction-to-Ambient A	t ≤ 10s	D	37	45	
Maximum Junction-to-Ambient AD	Steady-State	H_{\thetaJA}	66	80	℃/W



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC I	PARAMETERS					
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, \ V_{GS} = 0 V$	-8			V
I _{DSS} Zero Gate Voltage Drain Current	V_{DS} =-8V, V_{GS} =0V			-1	μА	
	Zero Gate Voltage Drain Gurient	T _J =55℃			-5	μΑ
I_{GSS}	Gate-Body leakage current	V_{DS} =0 V , V_{GS} = $\pm 5V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_{D}=-250\mu A$	-0.15	-0.4	-0.65	V
$I_{D(ON)}$	On state drain current	V_{GS} =-2.5V, V_{DS} =-5V	-32			Α
		V _{GS} =-2.5V, I _D =-8A		18	22	mΩ
		T _J =125℃		24.5	32	11122
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V_{GS} =-1.8V, I_D =-6A		22.6	28	mΩ
		V_{GS} =-1.5V, I_D =-4A		27.7	36	mΩ
		V_{GS} =-1.2V, I_D =-2A		39	53	mΩ
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-8A		33		S
V_{SD}	Diode Forward Voltage	$I_S=-1A, V_{GS}=0V$		-0.55	-1	V
Is	Maximum Body-Diode Continuous Current				-4	Α
DYNAMIC	CPARAMETERS					
C _{iss}	Input Capacitance			1465		pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-4V, f=1MHz		345		pF
C _{rss}	Reverse Transfer Capacitance			235		pF
R_g	Gate resistance	V_{GS} =0V, V_{DS} =0V, f=1MHz		10		Ω
SWITCH	NG PARAMETERS					
Q_g	Total Gate Charge			12.5	18	nC
Q_{gs}	Gate Source Charge	V_{GS} =-4.5V, V_{DS} =-4V, I_D =-8A		1.5		nC
Q_{gd}	Gate Drain Charge			3		nC
t _{D(on)}	Turn-On DelayTime			4		ns
t _r	Turn-On Rise Time	V_{GS} =-4.5V, V_{DS} =-4V, R_L =0.5 Ω ,		28		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		99		ns
t _f	Turn-Off Fall Time]		43		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =-8A, dI/dt=100A/μs		23		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =-8A, dI/dt=100A/μs		7		nC

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_{Δ} =25° C. The Power dissipation P_{DSM} is based on $R_{\theta JA}$ t \leqslant 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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Rev 0: April. 2012 Page 2 of 5 www.aosmd.com

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150 $^\circ$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial $T_J = 25^{\circ}$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

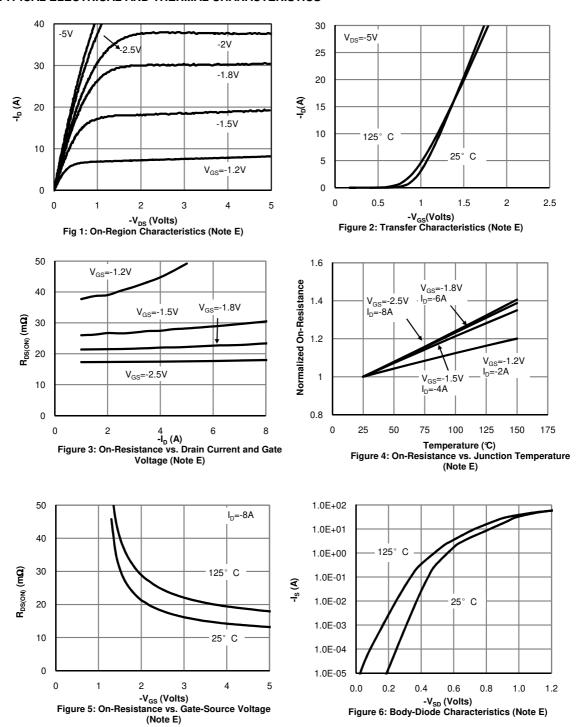
F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





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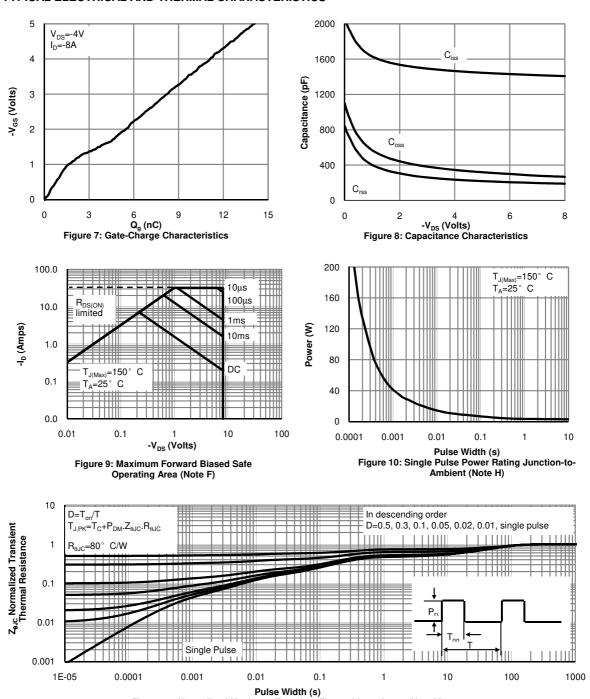
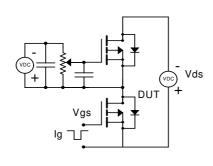
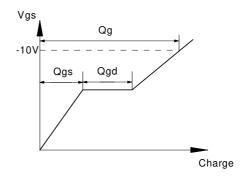


Figure 11: Normalized Maximum Transient Thermal Impedance (Note H)

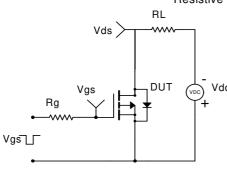


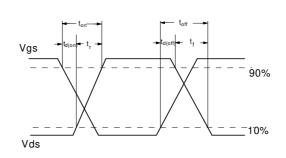
Gate Charge Test Circuit & Waveform



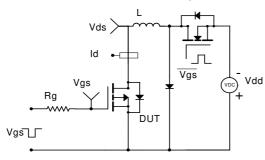


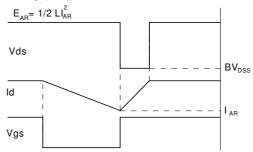
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

